

Integrated Device Technology, Inc. 6024 Silver Creek Valley Road, San Jose, CA - 95138

PRODUCT/	PROCESS CH	IANGE	NOTI	CE (PC	N)
Product Affected: F1478NLGA F1478NLGA8	DATE: 13-May-2019	MEANS C Product Back M Date Co Other	t Mark Iark	Traceability t	HANGED DEVICES: to the test location is y IDT and available on
Date Effective: 13-Jun-2019					
Contact: IDT PCN DESK		Attachmen	t:	Yes	☐ No
E-mail: <pre>pcndesk@idt.com</pre>			Please conta sample requ		sales representative for
DESCRIPTION AND PURPOSE OF CH	ANGE:				
 □ Die Technology □ Wafer Fabrication Process □ Assembly Process □ Equipment □ Material □ Testing ■ Manufacturing Site □ Data Sheet □ Other 	This notification is to adalternate facility for Tes IDT Penang, Malaysia a Attachment I details the	st process for facility.			g Sigurd, Taiwan as an nat are presently tested in
RELIABILITY/QUALIFICATION SUM There is no expected change to the product correlation data.		formance. I	Please refer	to Attachment	I for Electrical
CUSTOMER ACKNOWLEDGMENT OF IDT records indicate that you require written to grant approval or request additional information will be assumed that this change is accepted IDT reserves the right to ship either version on the earlier version has been depleted.	en notification of this charmation. If IDT does not table.	receive ack	nowledgeme	ent within 30 c	days of this notice
Customer:		Appro	oval for sh	ipments pri	ior to effective date.
Name/Date:	E-	Mail Addre	ess:		
Title:	Ph	none# /Fax#	·:		
CUSTOMER COMMENTS:					
IDT ACKNOWLEDGMENT OF RECEI	IPT:				
RECD. BY:		DATE: _			



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PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT I - PCN #: TB1904-05

PCN Type: Manufacturing Site - Alternate Test Location

Data Sheet Change: None

Detail Of Change:

This notification is to advise our customers that IDT is adding Sigurd, Taiwan as an alternate facility for Test process for the selective products that are presently tested in IDT Penang, Malaysia facility.

This change will allow IDT the flexibility to ship from either facilities and will provide the increased capacity, flexibility and shorter lead time to meet market demand.

There is no change in the Test processing flows. IDT has completed the electrical test correlation and based on the test results we do not anticipate any impact on device performance. The testing is fully compatible and transferrable between the test facilities with no change to the test coverage.

If you require samples to conduct evaluations, please contact your local sales representative to acknowledge this PCN and request samples.



PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT I - PCN #: TB1904-05

Qualification Information and Qualification Data: Electrical Test Correlation Results

Vehicle: F1478

Sample size: 8 good and 6 reject units; 10 cycles loop test correlation

Description	Existing Test (IDT, Penang)	Alternate Test (Sigurd, Taiwan)	
Tester Platform	J750	Ultra Flex	
Test Program	F1478_FT_rev0.4	F1478_UFlex_v1	
Test Site	Quad Site	Octal Site	
Test Temperature	Ambient	Ambient	
Test Correlation Results	100%	100%	
Number of Good Units	8 pcs	8 pcs	
8 good units datalog correlation	Passed	Passed	
Number of Loop Test	10	10	
8 good units datalog correlation	Passed	Passed	
Number of Reject Units	6 pcs	6 pcs	
6 reject units datalog correlation	Passed	Passed	